NXP Semiconductors
Technical Data

Document Number: MRFX1K80H
Rev. 1, 09/2018

RF Power LDMOS Transistor

High Ruggedness N-Channel Enhancement-Mode Lateral MOSFET

This high ruggedness device is designed for use in high VSWR industrial, medical, broadcast, aerospace and mobile radio applications. Its unmatched input and output design supports frequency use from 1.8 to 400 MHz.

MRFX1K80H

1.8–400 MHz, 1800 W CW, 65 V WIDEBAND RF POWER LDMOS TRANSISTOR



NI-1230H-4S

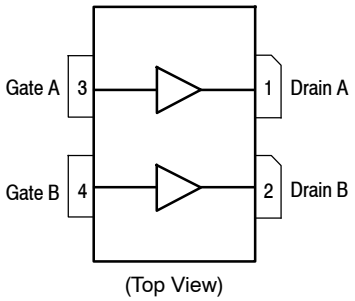
Typical Performance

Frequency (MHz)	Signal Type	V_{DD} (V)	P_{out} (W)	G_{ps} (dB)	η_D (%)
27 (1)	CW	65	1800 CW	27.8	75.6
64	Pulse (100 μsec, 10% Duty Cycle)	65	1800 Peak	27.1	69.5
81.36	CW	62	1800 CW	25.1	78.7
87.5–108 (2,3)	CW	60	1600 CW	23.6	82.5
123/128	Pulse (100 μsec, 10% Duty Cycle)	65	1800 Peak	25.9	69.0
144	CW	65	1800 CW	23.5	78.0
175	CW	60	1560 CW	23.5	75.9
174–230 Doherty (3)	DVB-T (8k OFDM)	63	250 Avg.	21.3	43.3
230 (4)	Pulse (100 μsec, 20% Duty Cycle)	65	1800 Peak	25.1	75.1
325	Pulse (12 μsec, 10% Duty Cycle)	63	1700 Peak	22.8	64.9

Load Mismatch/Ruggedness

Frequency (MHz)	Signal Type	VSWR	P_{in} (W)	Test Voltage	Result
230 (4)	Pulse (100 μsec, 20% Duty Cycle)	> 65:1 at all Phase Angles	14 Peak (3 dB Overdrive)	65	No Device Degradation

1. Measured in 27 MHz reference circuit (page 6).
2. Measured in 87.5–108 MHz broadband reference circuit (page 11).
3. The values shown are the center band performance numbers across the indicated frequency range.
4. Measured in 230 MHz production test fixture (page 17).



(Top View)

Note: The backside of the package is the source terminal for the transistor.

Figure 1. Pin Connections

Features

- Unmatched input and output allowing wide frequency range utilization
- Device can be used single-ended or in a push-pull configuration
- Qualified up to a maximum of 65 V_{DD} operation
- Characterized from 30 to 65 V for extended power range
- High breakdown voltage for enhanced reliability
- Suitable for linear application with appropriate biasing
- Integrated ESD protection with greater negative gate-source voltage range for improved Class C operation
- Lower thermal resistance option in over-molded plastic package: MRFX1K80N
- Included in NXP product longevity program with assured supply for a minimum of 15 years after launch

Typical Applications

- Industrial, scientific, medical (ISM)
  - Laser generation
  - Plasma generation
  - Particle accelerators
  - MRI, RF ablation and skin treatment
  - Industrial heating, welding and drying systems
- Radio and VHF TV broadcast
- Aerospace
  - HF communications
  - Radar

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Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	–0.5, +179	Vdc
Gate-Source Voltage	V_{GS}	–6.0, +10	Vdc
Storage Temperature Range	T_{stg}	–65 to +150	°C
Case Operating Temperature Range	T_C	–40 to +150	°C
Operating Junction Temperature Range (1,2)	T_J	–40 to +225	°C
Total Device Dissipation @ T_C = 25°C Derate above 25°C	P_D	2247 11.2	W W/°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (2,3)	Unit
Thermal Resistance, Junction to Case CW: Case Temperature 99°C, 1800 W CW, 65 Vdc, $I_{DQ(A+B)}$ = 150 mA, 98 MHz	$R_{\theta JC}$	0.09	°C/W
Thermal Impedance, Junction to Case Pulse: Case Temperature 65°C, 1800 W Peak, 100 μsec Pulse Width, 20% Duty Cycle, 65 Vdc, $I_{DQ(A+B)}$ = 100 mA, 230 MHz	$Z_{\theta JC}$	0.017	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	2, passes 2500 V
Charge Device Model (per JESD22-C101)	C3, passes 2000 V

Table 4. Electrical Characteristics (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Off Characteristics (4)					
Gate-Source Leakage Current (V_{GS} = 5 Vdc, V_{DS} = 0 Vdc)	I_{GSS}	—	—	1	μAdc
Drain-Source Breakdown Voltage (V_{GS} = 0 Vdc, I_D = 100 mAdc)	$V_{(BR)DSS}$	179	193	—	Vdc
Zero Gate Voltage Drain Leakage Current (V_{DS} = 65 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current (V_{DS} = 179 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	100	mAdc
On Characteristics					
Gate Threshold Voltage (4) (V_{DS} = 10 Vdc, I_D = 740 μAdc)	$V_{GS(th)}$	2.1	2.5	2.9	Vdc
Gate Quiescent Voltage (V_{DD} = 65 Vdc, $I_{D(A+B)}$ = 100 mAdc, Measured in Functional Test)	$V_{GS(Q)}$	2.4	2.8	3.2	Vdc
Drain-Source On-Voltage (4) (V_{GS} = 10 Vdc, I_D = 2.76 Adc)	$V_{DS(on)}$	—	0.21	—	Vdc
Forward Transconductance (4) (V_{DS} = 10 Vdc, I_D = 43 Adc)	g_{fs}	—	44.7	—	S

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at http://www.nxp.com/RF/calculators.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers.* Go to http://www.nxp.com/RF and search for AN1955.
4. Each side of device measured separately.

(continued)

Table 4. Electrical Characteristics (T_A = 25°C unless otherwise noted) **(continued)**

Characteristic	Symbol	Min	Typ	Max	Unit
Dynamic Characteristics (1)					
Reverse Transfer Capacitance (V_{DS} = 65 Vdc ± 30 mV(rms)ac @ 1 MHz, V_{GS} = 0 Vdc)	C_{rss}	—	2.9	—	pF
Output Capacitance (V_{DS} = 65 Vdc ± 30 mV(rms)ac @ 1 MHz, V_{GS} = 0 Vdc)	C_{oss}	—	203	—	pF
Input Capacitance (V_{DS} = 65 Vdc, V_{GS} = 0 Vdc ± 30 mV(rms)ac @ 1 MHz)	C_{iss}	—	760	—	pF
Functional Tests (In NXP Production Test Fixture, 50 ohm system) V_{DD} = 65 Vdc, $I_{DQ(A+B)}$ = 100 mA, P_{out} = 1800 W Peak (360 W Avg.), f = 230 MHz, 100 μsec Pulse Width, 20% Duty Cycle					
Power Gain	G_{ps}	24.0	25.1	26.5	dB
Drain Efficiency	η_D	70.0	75.1	—	%
Input Return Loss	IRL	—	–14.4	–9	dB

Table 5. Load Mismatch/Ruggedness (In NXP Production Test Fixture, 50 ohm system) $I_{DQ(A+B)}$ = 100 mA

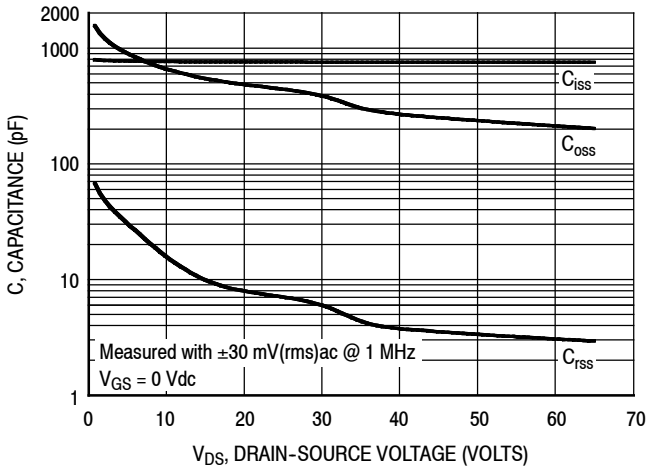
Frequency (MHz)	Signal Type	VSWR	P_{in} (W)	Test Voltage, V_{DD}	Result
230	Pulse (100 μsec, 20% Duty Cycle)	> 65:1 at all Phase Angles	14 W Peak (3 dB Overdrive)	65	No Device Degradation

Table 6. Ordering Information

Device	Tape and Reel Information	Package
MRFX1K80HR5	R5 Suffix = 50 Units, 56 mm Tape Width, 13-inch Reel	NI-1230H-4S

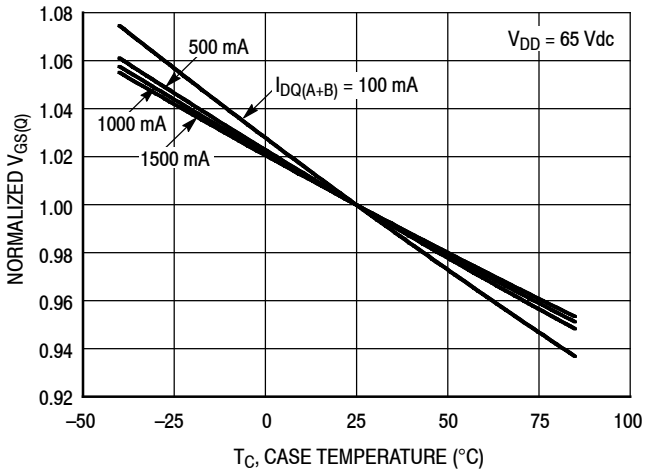
1. Each side of device measured separately.

TYPICAL CHARACTERISTICS



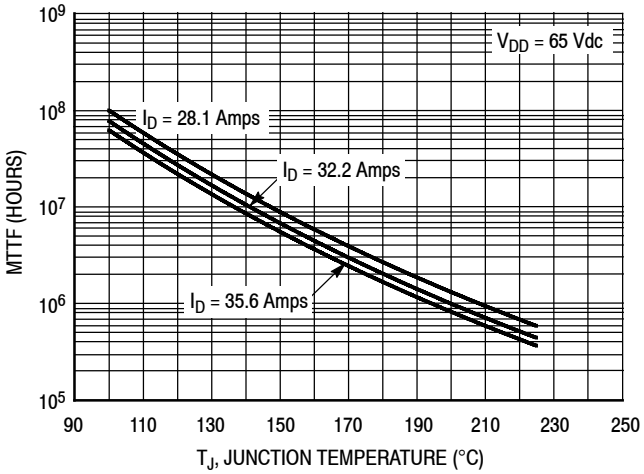
Note: Each side of device measured separately.

Figure 2. Capacitance versus Drain-Source Voltage



I_{DQ} (mA)	Slope (mV/°C)
100	–3.21
500	–2.79
1000	–2.69
1500	–2.61

Figure 3. Normalized V_{GS} versus Quiescent Current and Case Temperature



Note: MTTF value represents the total cumulative operating time under indicated test conditions.

MTTF calculator available at http:/www.nxp.com/RF/calculators.

Figure 4. MTTF versus Junction Temperature – CW

LINEAR MODEL

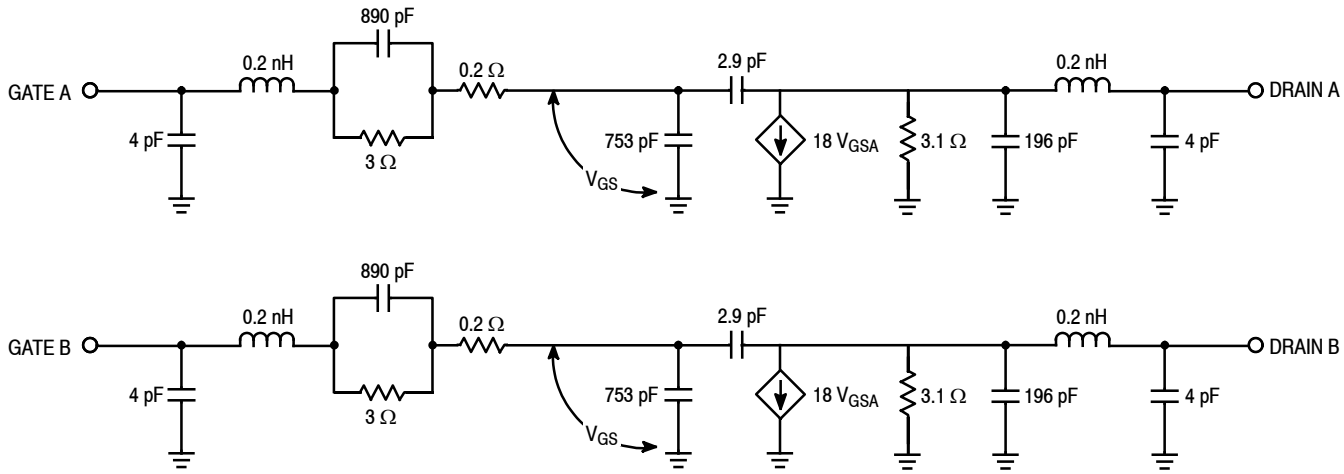


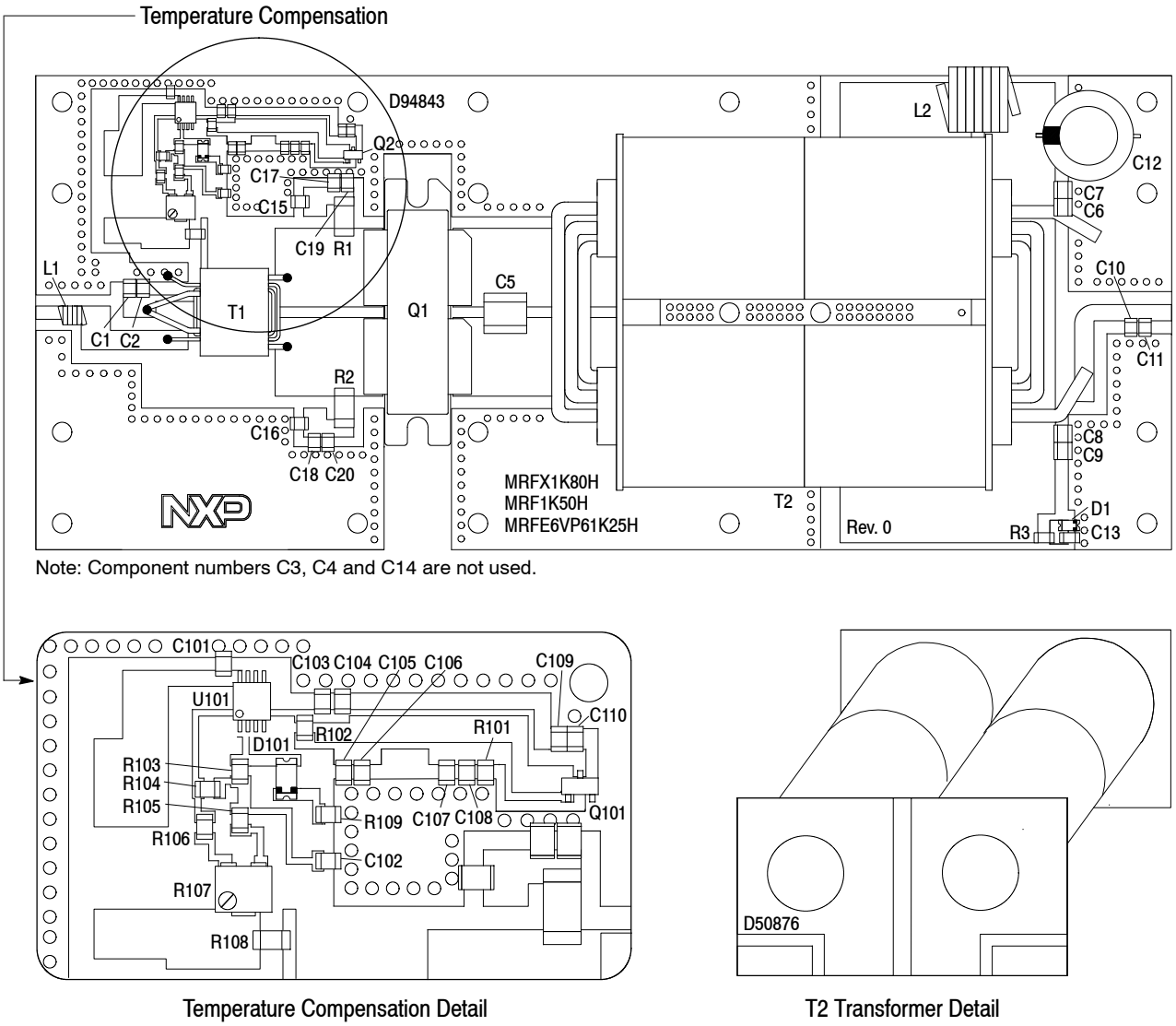
Figure 5. Simple Linear Model for the MRFX1K80H

27 MHz REFERENCE CIRCUIT – 2.9″ × 6.9″ (73 mm × 175 mm)

Table 7. 27 MHz Performance (In NXP Reference Circuit, 50 ohm system)
$I_{DQ(A+B)}$ = 200 mA, P_{in} = 3 W, CW

Frequency (MHz)	V_{DD} (V)	P_{out} (W)	G_{ps} (dB)	η_D (%)
27	50	1200	26.0	82.3
	57.5	1520	27.0	80.1
	65	1800	27.8	75.6

27 MHz REFERENCE CIRCUIT – 2.9″ × 6.9″ (73 mm × 175 mm)



Note: Component numbers C3, C4 and C14 are not used.

Figure 6. MRFX1K80H Reference Circuit Component Layout – 27 MHz

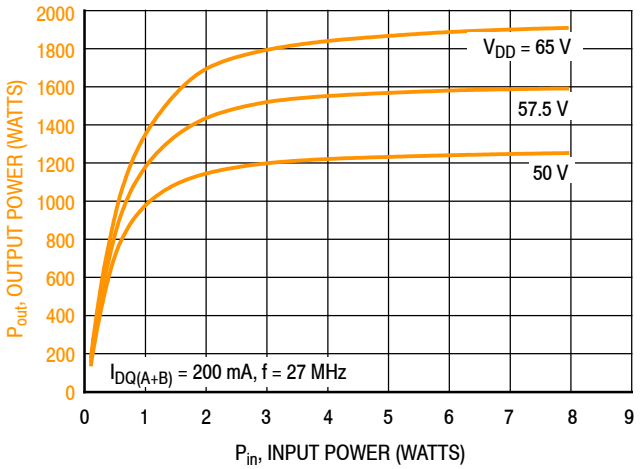
27 MHz REFERENCE CIRCUIT – 2.9″ × 6.9″ (73 mm × 175 mm)

Table 8. MRFX1K80H Reference Circuit Component Designations and Values – 27 MHz

Part	Description	Part Number	Manufacturer
C1, C17, C18	1000 pF Chip Capacitor	ATC100B102JT50XT	ATC
C2, C15, C16	39 K pF Chip Capacitor	ATC200B393KT50XT	ATC
C5	470 pF Chip Capacitor	ATC100C471JT2500XT	ATC
C6, C8	2.2 μF Chip Capacitor	HMK432B7225KM-T	Taiyo Yuden
C7, C9, C19, C20	470 pF Chip Capacitor	ATC100B471JT200XT	ATC
C10, C11	22 pF Chip Capacitor	ATC100B220JT500XT	ATC
C12	470 μF, 100 V Electrolytic Capacitor	MCGPR100V477M16X32-RH	Multicomp
C13	1000 pF Chip Capacitor	C2012X7R2E102M	TDK
D1	Green LED, 1206	LG N971-KN-1	OSRAM
L1	82 nH Inductor	1812SMS-82NJLC	Coilcraft
L2	7 Turns, #16 AWG, ID = 10 mm Inductor, Hand Wound	8074	Belden
Q1	RF Power LDMOS Transistor	MRFX1K80H	NXP
R1, R2	33 Ω, 3 W Chip Resistor	1-2176070-3	TE Connectivity
R3	9.1 kΩ, 1/4 W Chip Resistor	CRCW12069K10FKEA	Vishay
PCB	Arlon TC350 0.030″ ε_r = 3.5	D94843	MTL
Transformer			
T1 Core	Multi-Aperture Core, 43 Material	2843000302	Fair-Rite
T1 Primary	2 Turns, #20 AWG Magnetic Wire	8076	Belden
T1 Secondary	1 Turn, #24 AWG Teflon Wire	5854/7 BL005	Alpha Wire
T2 Core	61 Round Cable Core, x4	2661102002	Fair-Rite
T2 Primary	Copper Pipe, Type L, ID = 3/8″, OD = 1/2″, cut to 2.4″	LH03010	Mueller
T2 Secondary	3 Turns, #16 AWG PTFE Covered Wire, Twisted	TEF16	RF Parts Company
T2 PCB	Arlon TC350 0.030″ ε_r = 3.5, x2	D50876	MTL
Temperature Compensation			
C101, C102, C104, C106, C108, C110	1 μF Chip Capacitor	GRM21BR71H105KA12L	Murata
C103, C105, C107, C109	1 nF Chip Capacitor	C2012X7R2E102M	TDK
D101	Red LED, 1206	LH N974-KN-1	OSRAM
Q101	NPN Bipolar Transistor	BC847ALT1G	ON Semiconductor
R101	2.2 kΩ, 1/8 W Chip Resistor	CRCW08052K20JNEA	Vishay
R102, R109	1.2 kΩ, 1/8 W Chip Resistor	CRCW08051K20FKEA	Vishay
R103	10 Ω, 1/8 W Chip Resistor	RK73H2ATTD10R0F	KOA Speer
R104	1 kΩ, 1/8 W Chip Resistor	RR1220P-102-D	Susumu
R105	3.9 kΩ, 1/8 W Chip Resistor	CRCW08053K90JNEA	Vishay
R106	200 Ω, 1/8 W Chip Resistor	CRCW0805200RJNEA	Vishay
R107	5 kΩ Multi-turn Cermet Trimming Potentiometer, 11 Turns	3224W-1-502E	Bourns
R108	10 Ω, 1/4 W Chip Resistor	CRCW120610R0JNEA	Vishay
U101	Voltage Regulator 5 V, Micro8	LP2951ACDMR2G	ON Semiconductor

Note: Refer to MRFX1K80H's printed circuit boards and schematics to download the 27 MHz heatsink drawing.

TYPICAL CHARACTERISTICS



f (MHz)	V_{DD} (V)	P1dB (W)	P_{sat} (W)
27	50	825	1250
	57.5	1010	1600
	65	1150	1900

Figure 7. CW Output Power versus Input Power and Drain-Source Voltage

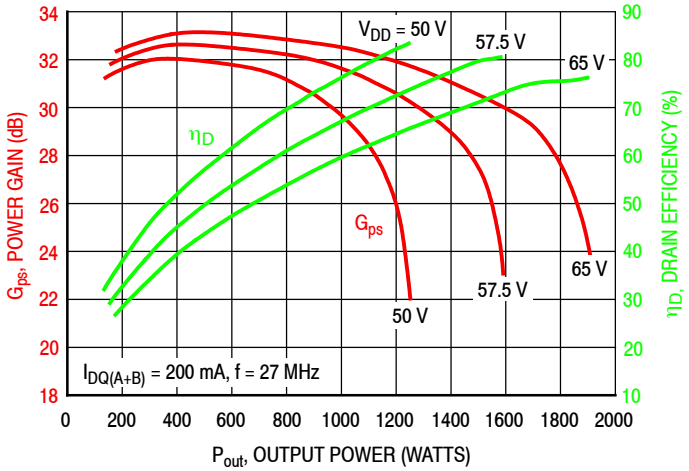


Figure 8. Power Gain and Drain Efficiency versus CW Output Power and Drain-Source Voltage

27 MHz REFERENCE CIRCUIT

f MHz	Z_{source} Ω	Z_{load} Ω
27	8.70 + j6.28	6.21 + j2.68

Z_{source} = Test circuit impedance as measured from gate to gate, balanced configuration.

Z_{load} = Test circuit impedance as measured from drain to drain, balanced configuration.

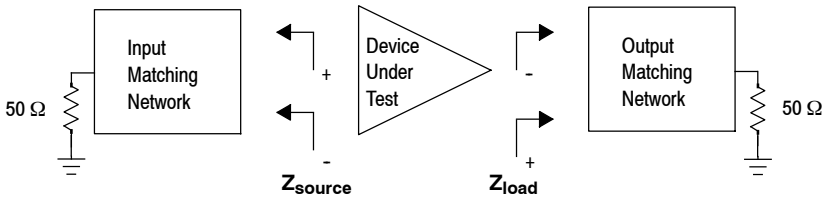


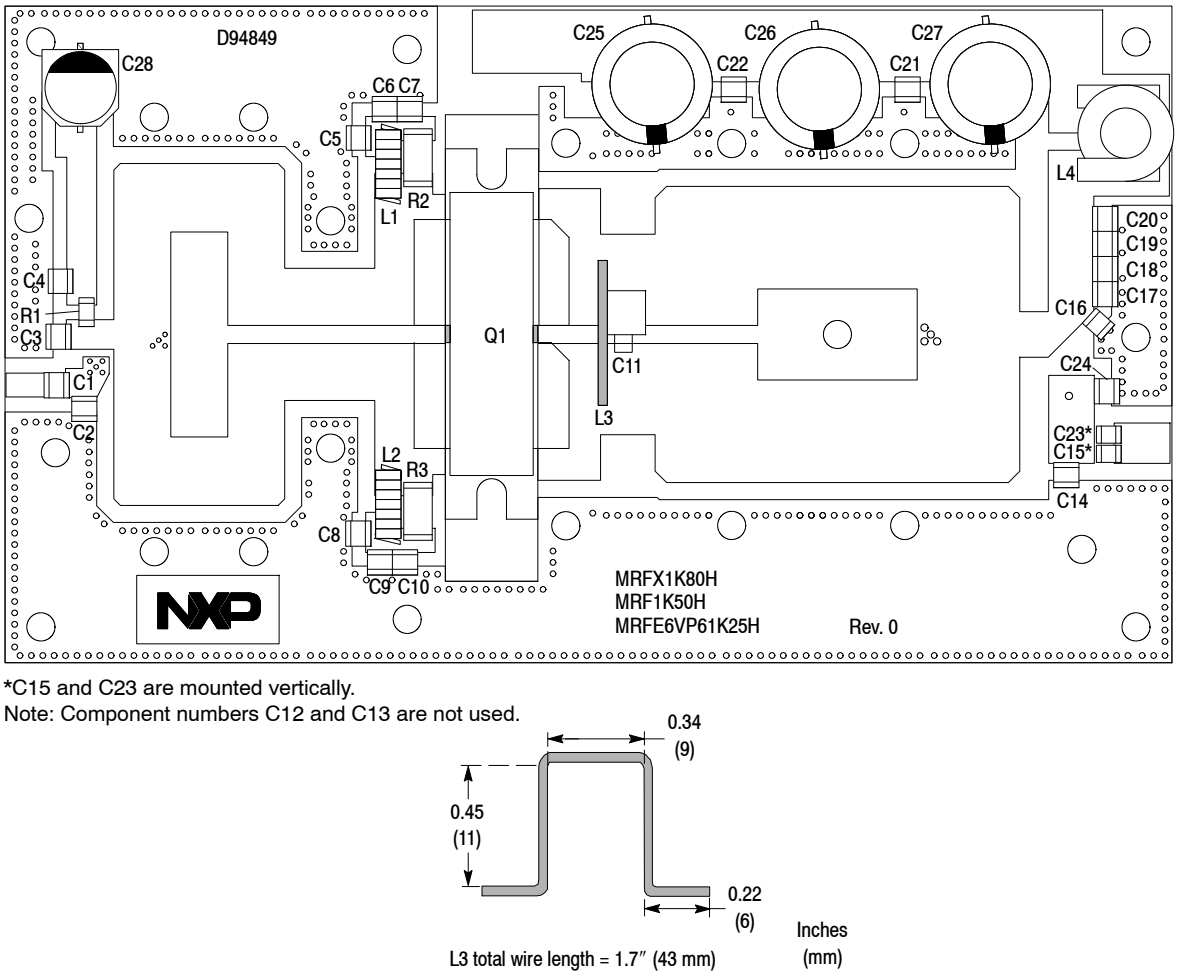
Figure 9. Series Equivalent Source and Load Impedance – 27 MHz

87.5–108 MHz BROADBAND REFERENCE CIRCUIT – 2.9″ × 5.1″ (73 mm × 130 mm)

Table 9. 87.5–108 MHz Broadband Performance (In NXP Reference Circuit, 50 ohm system)
$I_{DQ(A+B)}$ = 200 mA, P_{in} = 7 W, CW

Frequency (MHz)	V_{DD} (V)	P_{out} (W)	G_{ps} (dB)	η_D (%)
87.5	60	1521	23.4	84.9
98	60	1600	23.6	82.5
108	60	1556	23.5	80.0

87.5–108 MHz BROADBAND REFERENCE CIRCUIT – 2.9″ × 5.1″ (73 mm × 130 mm)



*C15 and C23 are mounted vertically.
Note: Component numbers C12 and C13 are not used.

Figure 10. MRFX1K80H 87.5–108 MHz Broadband Reference Circuit Component Layout

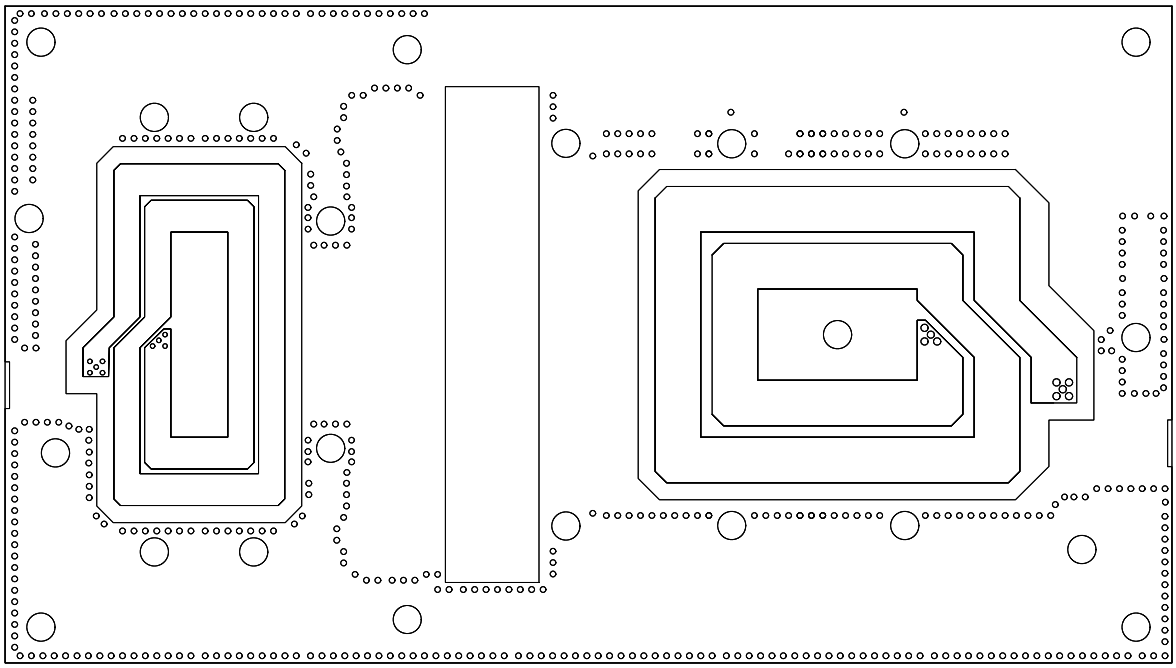


Figure 11. MRFX1K80H 87.5–108 MHz Broadband Reference Circuit Component Layout – Bottom

Table 10. MRFX1K80H 87.5–108 MHz Broadband Reference Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C3, C6, C9, C18, C19, C20, C21, C22	1000 pF Chip Capacitor	ATC100B102JT50XT	ATC
C2	33 pF Chip Capacitor	ATC100B330JT500XT	ATC
C4, C5, C8	10,000 pF Chip Capacitor	ATC200B103KT50XT	ATC
C7, C10, C15, C16, C17, C23	470 pF Chip Capacitor	ATC100B471JT200XT	ATC
C11	100 pF, 300 V Mica Capacitor	MIN02-002EC101J-F	CDE
C14, C24	12 pF Chip Capacitor	ATC100B120GT500XT	ATC
C25, C26, C27	220 μF, 100 V Electrolytic Capacitor	EEV-FC2A221M	Panasonic–ECG
C28	22 μF, 35 V Electrolytic Capacitor	UUD1V220MCL1GS	Nichicon
L1, L2	17.5 nH Inductor, 6 Turns	B06TJLC	Coilcraft
L3	1.5 mm Non–Tarnish Silver Plated Copper Wire, Total Wire Length = 1.7″/43 mm	SP1500NT-001	Scientific Wire Company
L4	22 nH Inductor	1212VS-22NMEB	Coilcraft
Q1	RF Power LDMOS Transistor	MRFX1K80H	NXP
R1	10 Ω, 1/4 W Chip Resistor	CRCW120610R0JNEA	Vishay
R2, R3	33 Ω, 2 W Chip Resistor	1-2176070-3	TE Connectivity
Thermal Pad	TG Series Soft Thermal Conductive Pad	TG6050-150-150-5.0-0	t-Global Technology
PCB	Arlon TC350 0.030″, ε_r = 3.5	D94849	MTL

Note: Refer to MRFX1K80H's printed circuit boards and schematics to download the 87.5–108 MHz heatsink drawing.

TYPICAL CHARACTERISTICS – 87.5–108 MHz, 60 V BROADBAND REFERENCE CIRCUIT

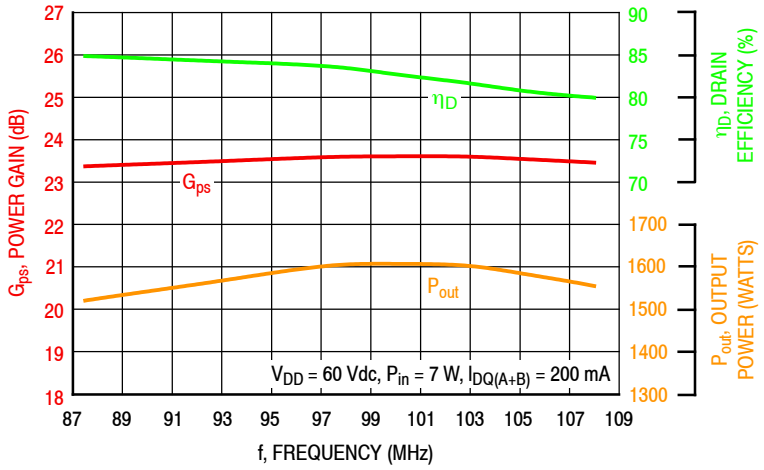


Figure 12. Power Gain, Drain Efficiency and CW Output Power versus Frequency at a Constant Input Power

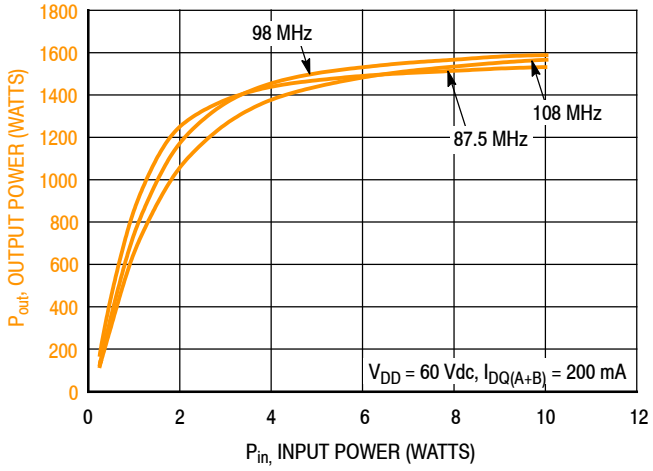


Figure 13. CW Output Power versus Input Power and Frequency

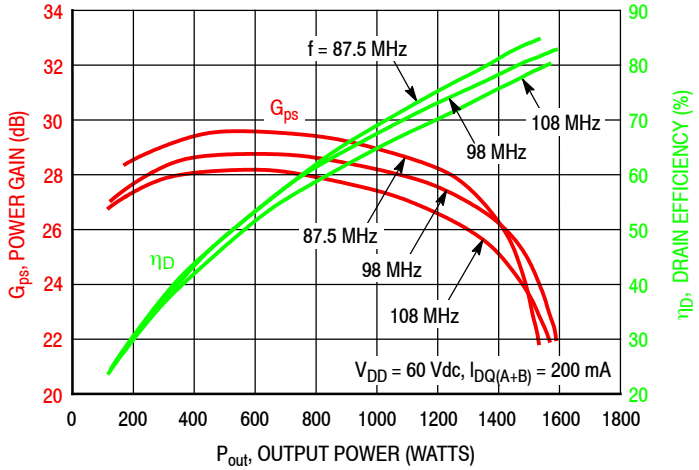
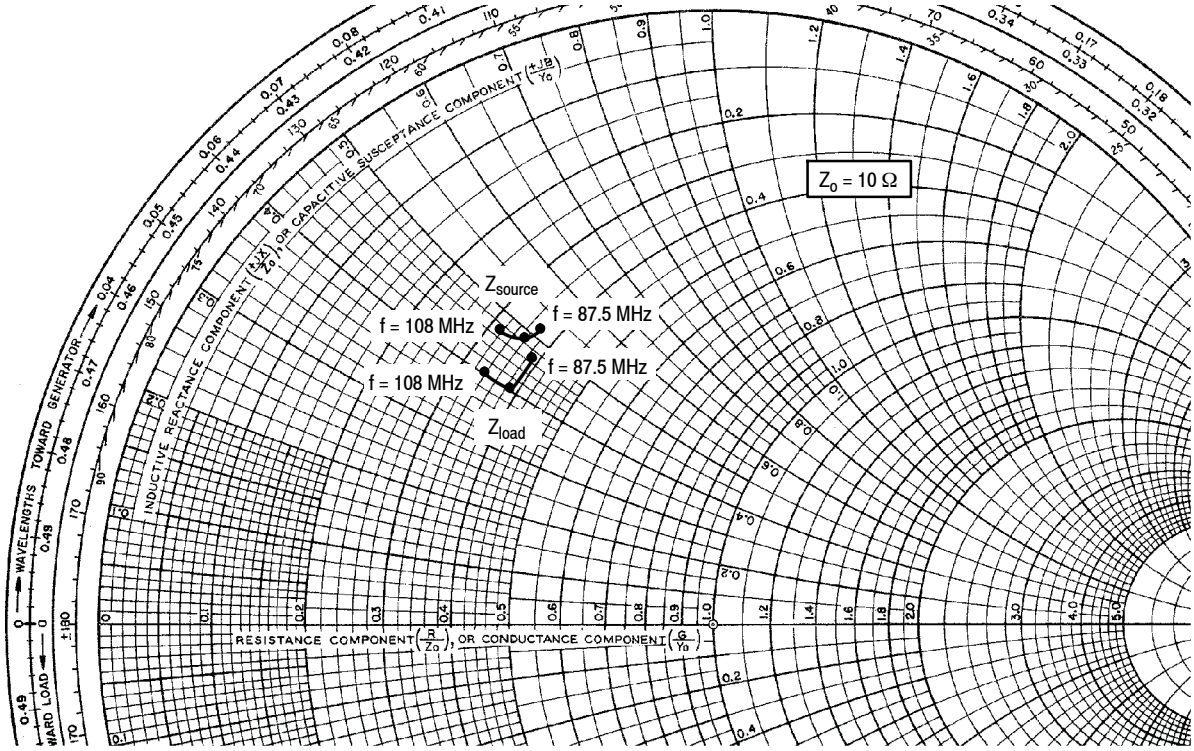


Figure 14. Power Gain and Drain Efficiency versus CW Output Power and Frequency

87.5–108 MHz BROADBAND REFERENCE CIRCUIT



f MHz	Z_{source} Ω	Z_{load} Ω
87.5	3.69 + j5.19	3.90 + j4.73
98	3.60 + j4.90	3.88 + j3.99
108	3.16 + j4.69	3.35 + j3.95

Z_{source} = Test circuit impedance as measured from gate to gate, balanced configuration.

Z_{load} = Test circuit impedance as measured from drain to drain, balanced configuration.

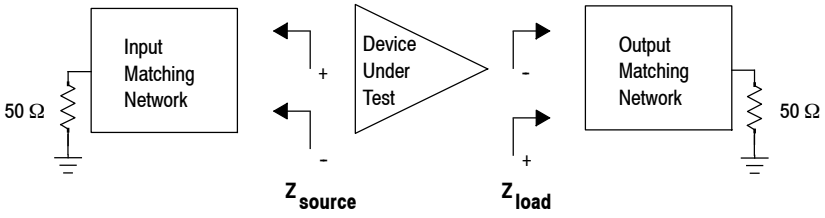
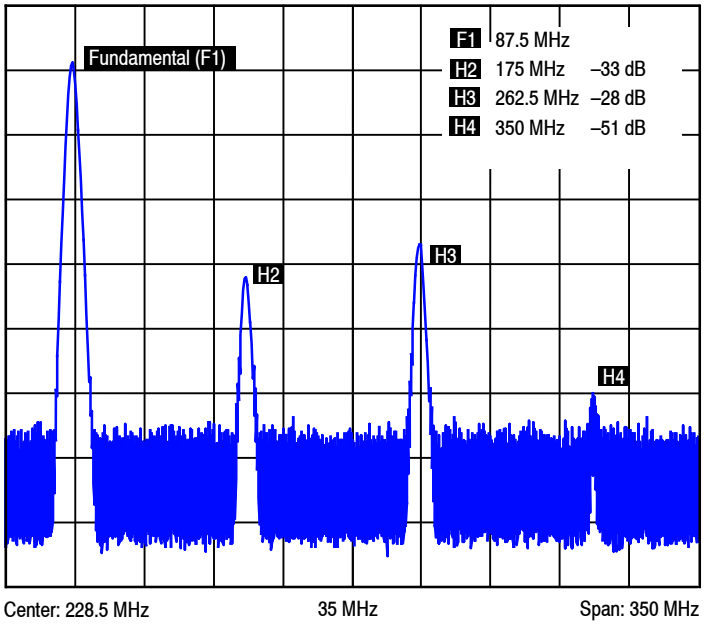


Figure 15. Broadband Series Equivalent Source and Load Impedance – 87.5–108 MHz

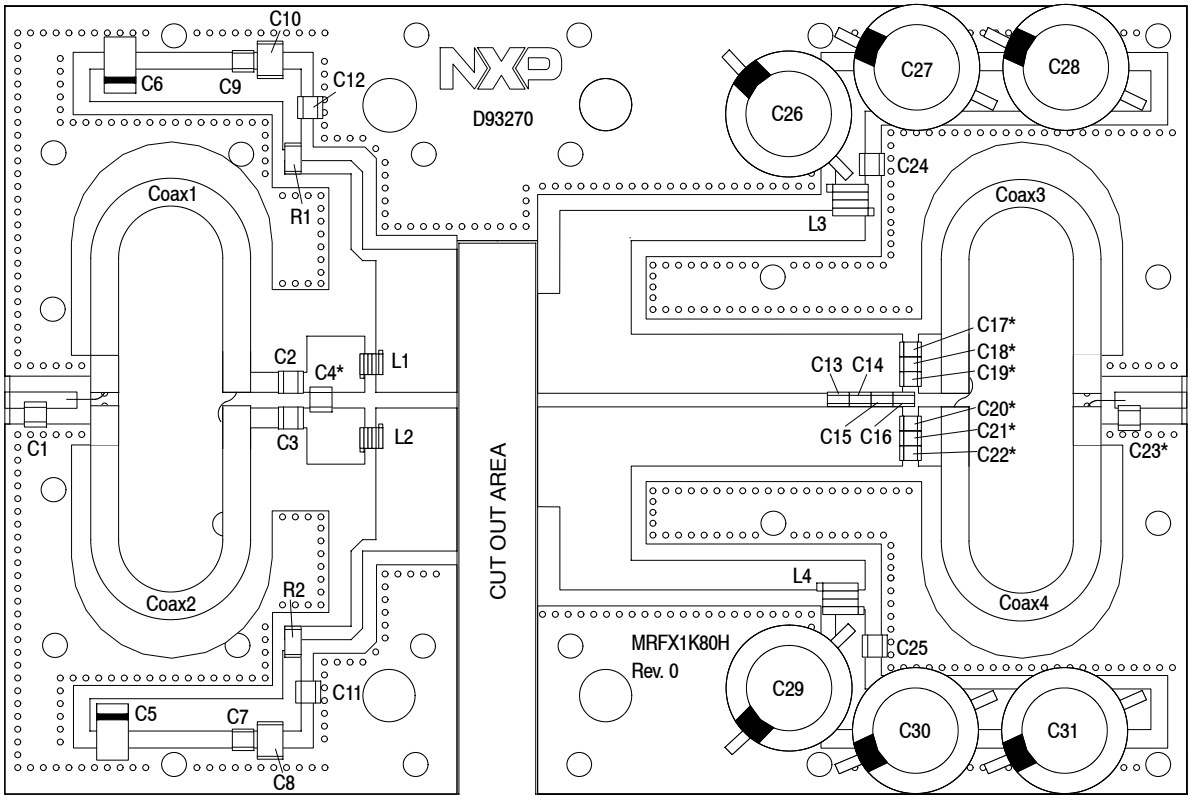
HARMONIC MEASUREMENTS — 87.5–108 MHz
BROADBAND REFERENCE CIRCUIT



H2 (175 MHz)	H3 (262.5 MHz)	H4 (350 MHz)
–33 dB	–28 dB	–51 dB

Figure 16. 87.5 MHz Harmonics @ 1300 W CW

230 MHz PRODUCTION TEST FIXTURE – 6.0″ × 4.0″ (152 mm × 102 mm)



*C4, C17, C18, C19, C20, C21, C22 and C23 are mounted vertically.

Figure 17. MRFX1K80H Test Fixture Component Layout – 230 MHz

Table 11. MRFX1K80H Test Fixture Component Designations and Values – 230 MHz

Part	Description	Part Number	Manufacturer
C1, C2, C3	22 pF Chip Capacitor	ATC100B220JT500XT	ATC
C4	27 pF Chip Capacitor	ATC100B270JT500XT	ATC
C5, C6	22 μF, 35 V Tantalum Capacitor	T491X226K035AT	Kemet
C7, C9	0.1 μF Chip Capacitor	CDR33BX104AKWS	AVX
C8, C10	220 nF Chip Capacitor	C1812C224K5RACTU	Kemet
C11, C12, C24, C25	1000 pF Chip Capacitor	ATC100B102JT50XT	ATC
C13	24 pF Chip Capacitor	ATC800R240JT500XT	ATC
C14, C15, C16	20 pF Chip Capacitor	ATC800R200JT500XT	ATC
C17, C18, C19, C20, C21, C22	240 pF Chip Capacitor	ATC100B241JT200XT	ATC
C23	7.5 pF Chip Capacitor	ATC100B7R5CT500XT	ATC
C26, C27, C28, C29, C30, C31	470 μF, 100 V Electrolytic Capacitor	MCGPR100V477M16X32-RH	Multicomp
Coax1, 2, 3, 4	25 Ω Semi Rigid Coax Cable, 2.2″ Shield Length	UT-141C-25	Micro-Coax
L1, L2	5 nH Inductor, 2 Turns	A02TJLC	Coilcraft
L3, L4	6.6 nH Inductor, 2 Turns	GA3093-ALC	Coilcraft
R1, R2	10 Ω, 1/4 W Chip Resistor	CRCW120610R0JNEA	Vishay
PCB	Arlon AD255A 0.030″, ε_r = 2.55	D93270	MTL

TYPICAL CHARACTERISTICS — 230 MHz, T_C = 25°C
PRODUCTION TEST FIXTURE

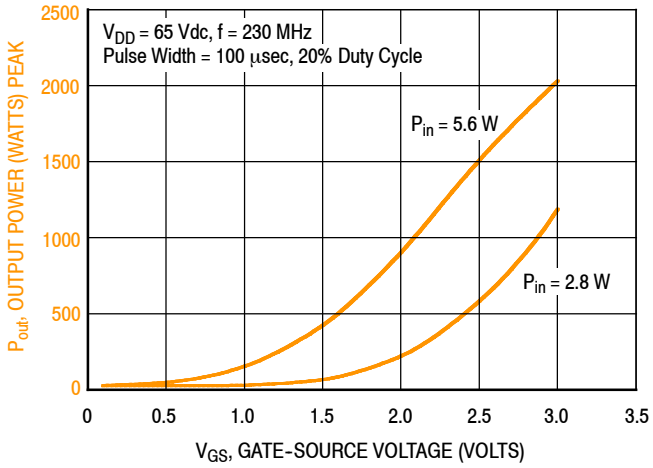
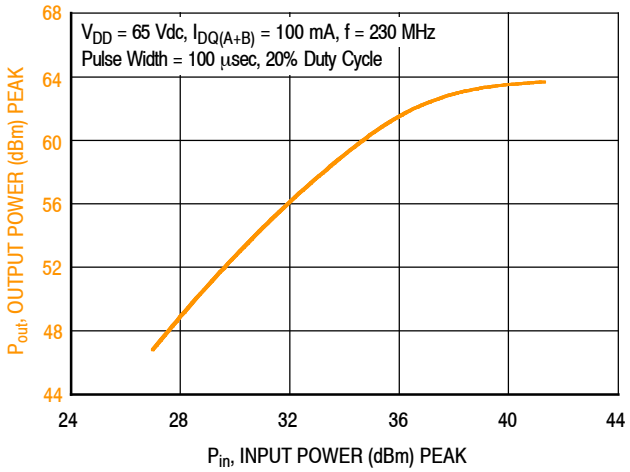


Figure 18. Output Power versus Gate-Source Voltage at a Constant Input Power



f (MHz)	P1dB (W)	P3dB (W)
230	2080	2300

Figure 19. Output Power versus Input Power

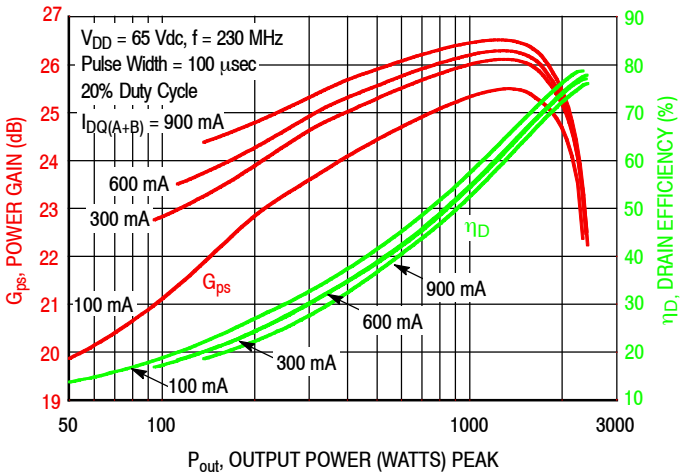


Figure 20. Power Gain and Drain Efficiency versus Output Power and Quiescent Current

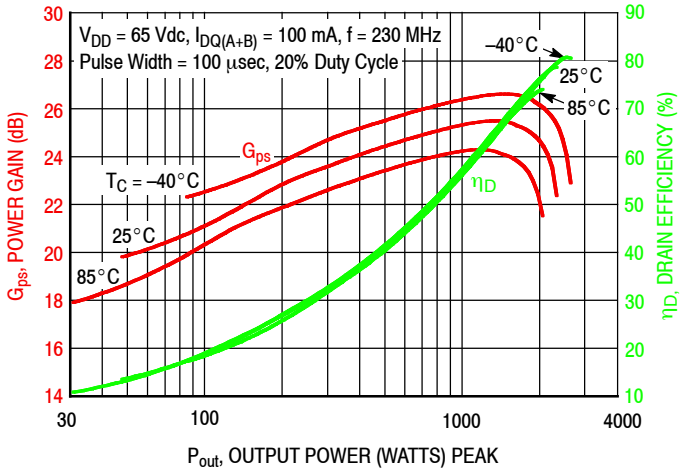


Figure 21. Power Gain and Drain Efficiency versus Output Power

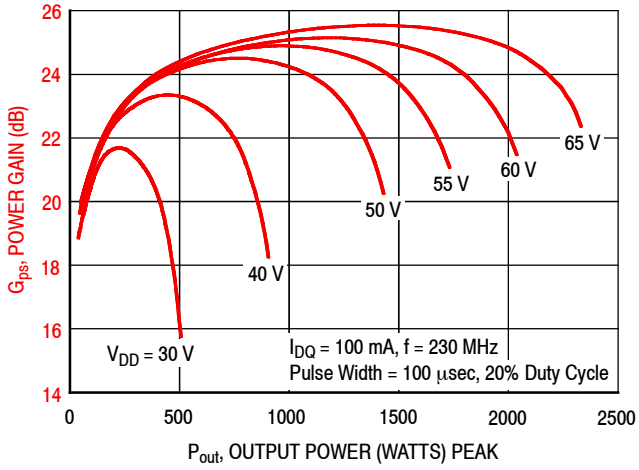


Figure 22. Power Gain versus Output Power and Drain-Source Voltage

230 MHZ PRODUCTION TEST FIXTURE

f MHz	Z_{source} Ω	Z_{load} Ω
230	1.1 + j2.7	2.2 + j2.9

Z_{source} = Test fixture impedance as measured from gate to gate, balanced configuration.

Z_{load} = Test fixture impedance as measured from drain to drain, balanced configuration.

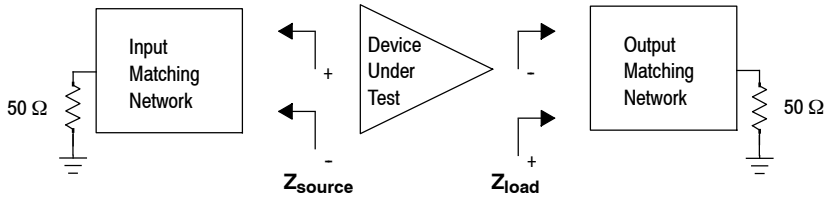
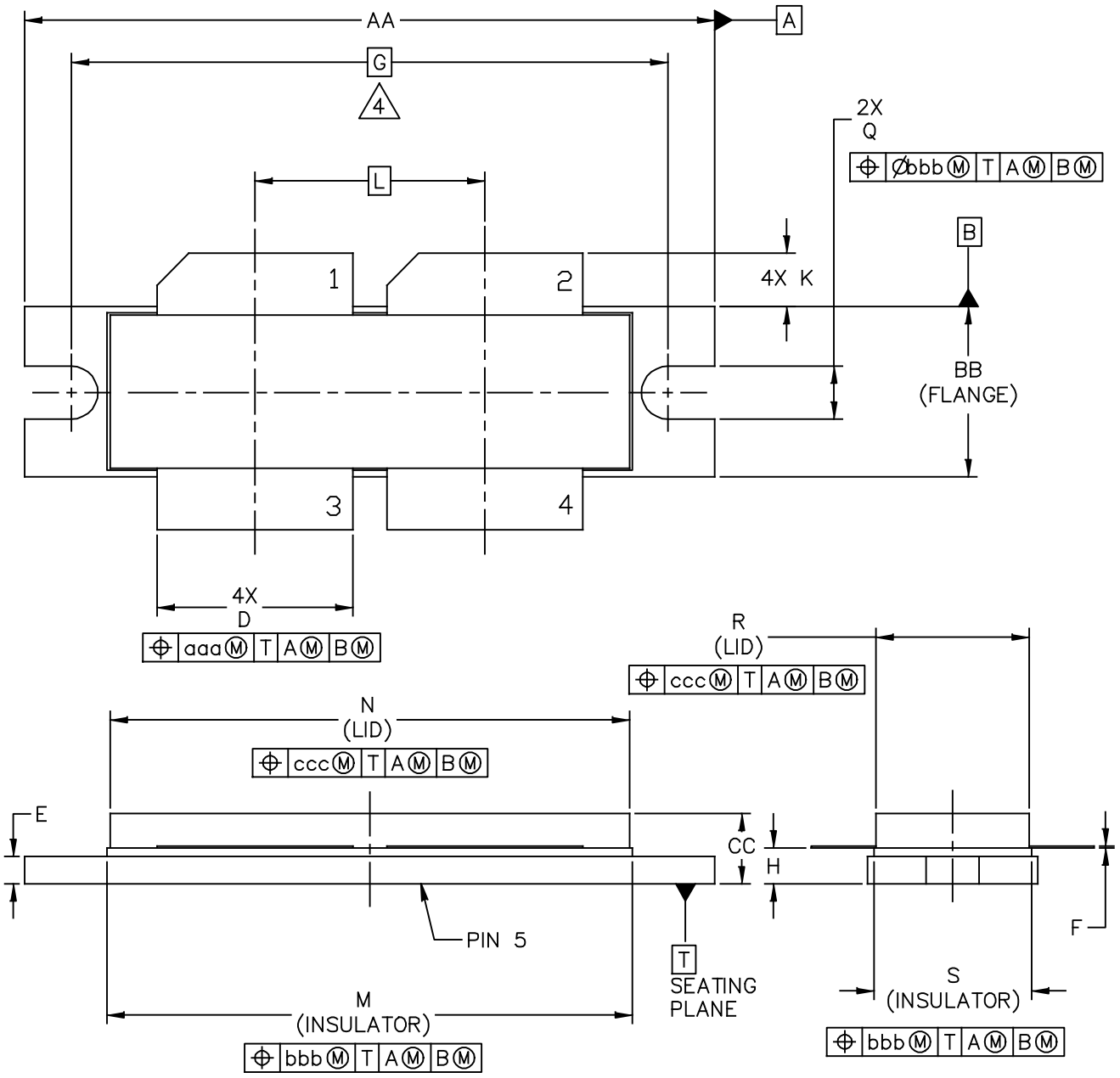


Figure 23. Series Equivalent Source and Load Impedance – 230 MHz

PACKAGE DIMENSIONS



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	STANDARD: NON−JEDEC	
	SOT1787−1	03 MAR 2016

NOTES:

1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M–1994.
2. CONTROLLING DIMENSION: INCH
3. DIMENSION H IS MEASURED .030 INCH (0.762 MM) AWAY FROM PACKAGE BODY.
4. RECOMMENDED BOLT CENTER DIMENSION OF 1.52 INCH (38.61 MM) BASED ON M3 SCREW.

DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX	DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX
AA	1.615	1.625	41.02	41.28	N	1.218	1.242	30.94	31.55
BB	.395	.405	10.03	10.29	Q	.120	.130	3.05	3.30
CC	.170	.190	4.32	4.83	R	.355	.365	9.02	9.27
D	.455	.465	11.56	11.81	S	.365	.375	9.27	9.53
E	.062	.066	1.57	1.68					
F	.004	.007	0.10	0.18					
G	1.400 BSC		35.56 BSC		aaa	.013		0.33	
H	.082	.090	2.08	2.29	bbb	.010		0.25	
K	.117	.137	2.97	3.48	ccc	.020		0.51	
L	.540 BSC		13.72 BSC						
M	1.219	1.241	30.96	31.52					

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SOT1787–1 03 MAR 2016

PRODUCT DOCUMENTATION, SOFTWARE AND TOOLS

Refer to the following resources to aid your design process.

Application Notes

- AN1908: Solder Reflow Attach Method for High Power RF Devices in Air Cavity Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

Development Tools

- Printed Circuit Boards

To Download Resources Specific to a Given Part Number:

1. Go to http://www.nxp.com/RF
2. Search by part number
3. Click part number link
4. Choose the desired resource from the drop down menu

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Aug. 2017	• Initial release of data sheet
1	Sept. 2018	• Typical Performance table: updated values for 81.36 MHz reference circuit; added performance information for 175 MHz reference circuit and 174–230 MHz Doherty reference circuit, p. 1 • Feature bullets: updated Aerospace feature bullets, p. 1 • Fig. 3, Normalized V_{GS} versus Quiescent Current and Case Temperature: corrected 50 Vdc to 65 Vdc to reflect actual performance in graph, p. 4 • Fig. 5, Linear Model: added simple linear model for MRFX1K80H, p. 5 • Fig. 10 (previously Fig. 9), 87.5–108 MHz Broadband Reference Circuit: added note regarding components not used, p. 12 • Fig. 20 (previously Fig. 19), Power Gain and Drain Efficiency versus Output Power and Quiescent Current: updated graph to reflect correct Drain Efficiency performance. Output Power axis value “3” changed to “50” to reflect actual output power performance, p. 18

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